

Region 10 Women in Engineering (WIE)

Call for Proposal

Visibility Enhancement through Events Program (VEEP)

Scope of proposals

All proposed projects should meet the Mission and Vision of IEEE WIE:

http://www.ieee.org/membership_services/membership/women/women_about.html

Objectives of VEEP

To enhance the visibility of R10 female engineering and students, to enhance the networking and knowledge sharing of them in [IEEE global and R10 flagship events, or cross-section events](#), as well as in website/facebook/twitter page

Proposal Conditions

Each WIE Affinity Group can submit one proposal.

Each activity proposal should meet WIE Mission & Vision/scope and should be held jointly with Global or R10 flagship events between **May to December 2017**. If the activity/expense reports are not submitted on time, they cannot receive the WIE fund.

SECTION is encouraged to coordinate with SECTION WIE AG and Student Branch WIE AGs to comprehensively and strategically propose WIE activities.

Proposal must be endorsed and submitted by either WIE AG Chair or Section Chair.

[Mandatory requirement] Policy of Section matching fund:

1. Large SECTION must cover at least 50% of the proposed project(s) cost.
2. Medium SECTION must cover at least 25% of the proposed project(s) cost.
3. Other sources of support with equivalent percentage can be considered in case there is no support from SECTION.

The funding support of each proposal is limited up to USD 400. Up to 5 proposals will be selected. Please quote the budget in US dollars only (please do not use local currency in the proposal).

Proposal Submission form (Online)

<http://ieee.fluidsveys.com/surveys/R0/r10-wie-veep-proposal-form-2017/>

Also available at R10 WIE website: <http://wie.ieeer10.org/>

Important Date

Proposal submission deadline: April 20, 2017

Notification of Decision: April 30, 2017

Contact Info

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